

# MATERIALS DISCOVERY FOR FUEL CELLS

## NEW OPPORTUNITIES AT THE INTERSECTION OF CONSTRAINT REASONING AND LEARNING

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Computer Science

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Computer Science

Materials Science/Physics

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**CompSust'12**

# Motivation



## Cornell Fuel Cell Institute

Mission: develop **new materials** for **fuel cells**.

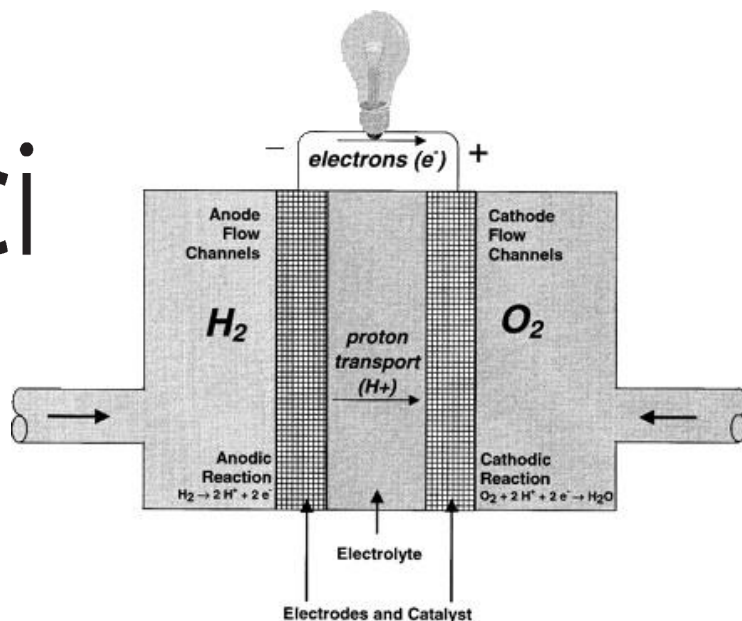


Figure 1. Fuel cell schematic.  
Source: Annual Reviews of Energy and the Environment. <http://energy.annualreviews.org/cgi/content/full/24/1/281>

An **Electrocatalyst** must:

- 1) Be electronically **conducting**
- 2) **Facilitate** both reactions

**Platinum** is the best known metal to fulfill that role, but:

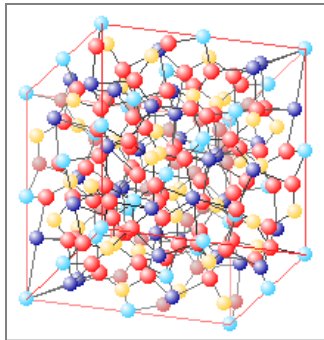
- 1) The reaction rate is still considered slow (causing **energy loss**)
- 2) Platinum is fairly **costly**, **intolerant** to fuel **contaminants**, and has a **short lifetime**.

**Goal:** Find an **intermetallic compound** that is a better catalyst than Pt.

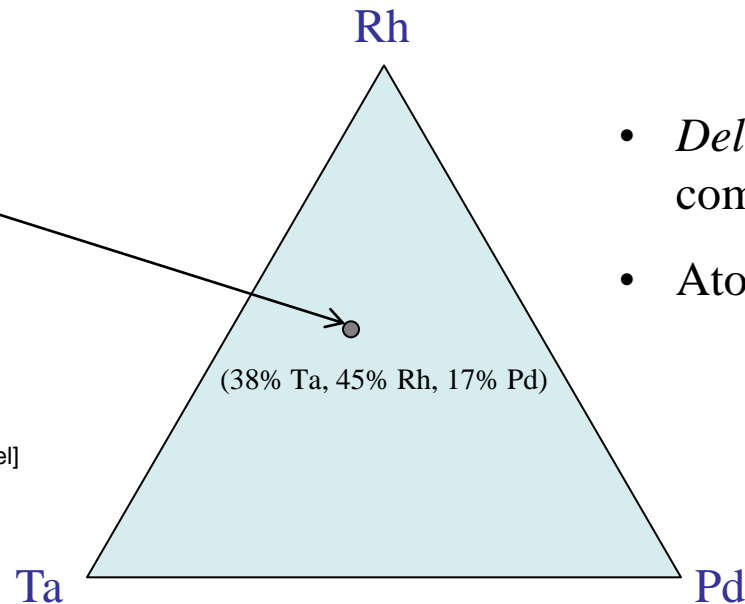
# Motivation

## Recipe for finding alternatives to Platinum

- 1) *In a vacuum chamber, place a silicon wafer.*
- 2) *Add three metals.*
- 3) *Mix until smooth, using three sputter guns.*
- 4) *Bake for 2 hours at 650°C*



[Source: *Pyrotope*, Sebastien Merkel]

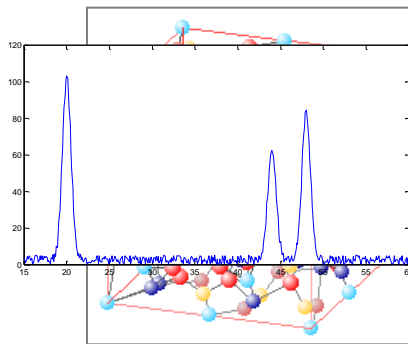


- *Deliberately inhomogeneous composition on Si wafer*
- *Atoms are intimately mixed*

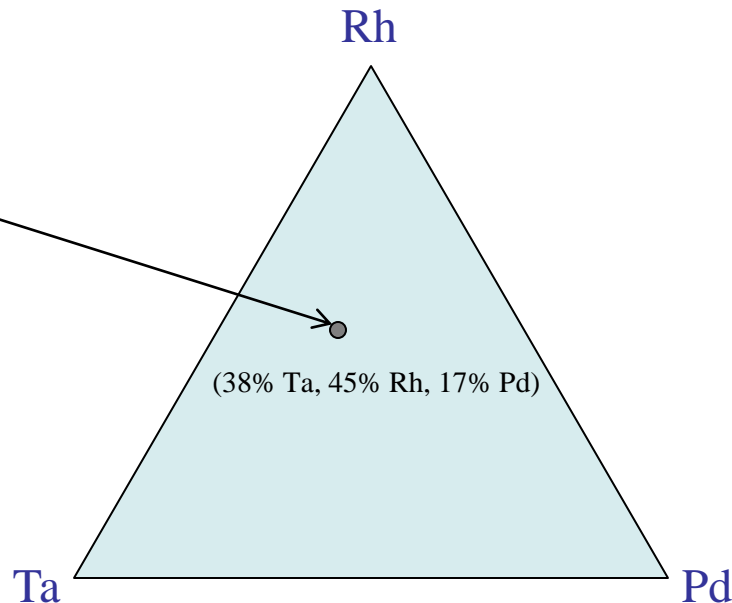
# Motivation

## Identifying crystal structure using **X-Ray Diffraction** at CHESS

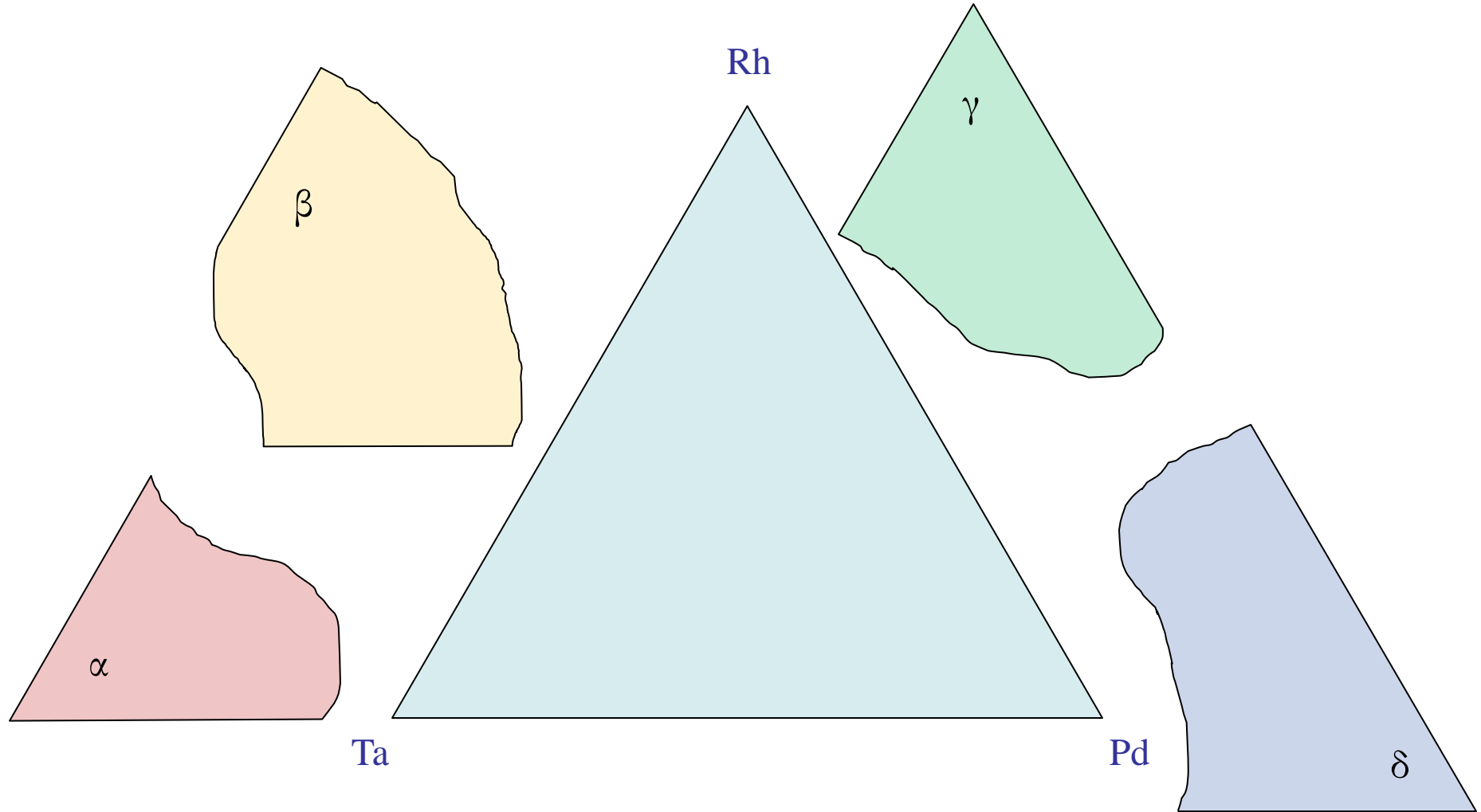
- XRD pattern **characterizes** the underlying **crystal** fairly well
- **Expensive** experimentations: Bruce van Dover's research team has access to the facility **one week every year**.



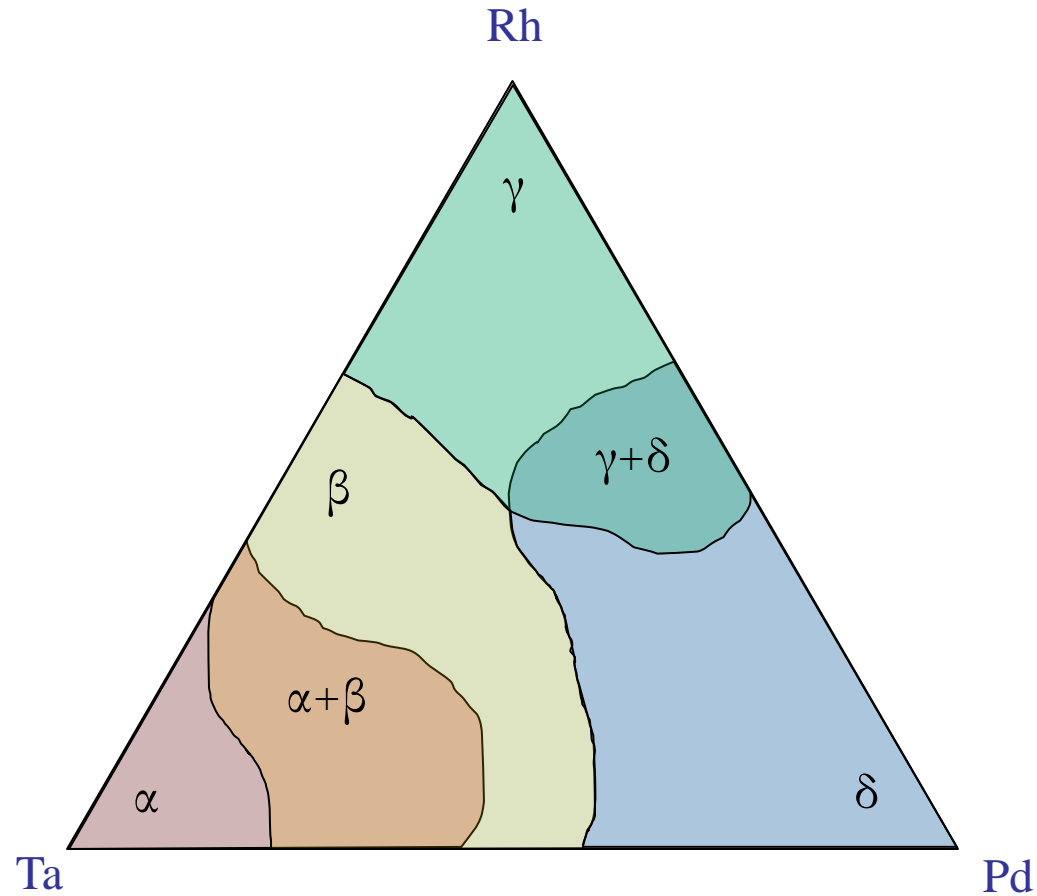
[Source: *Pyrotope*, Sebastien Merkel]



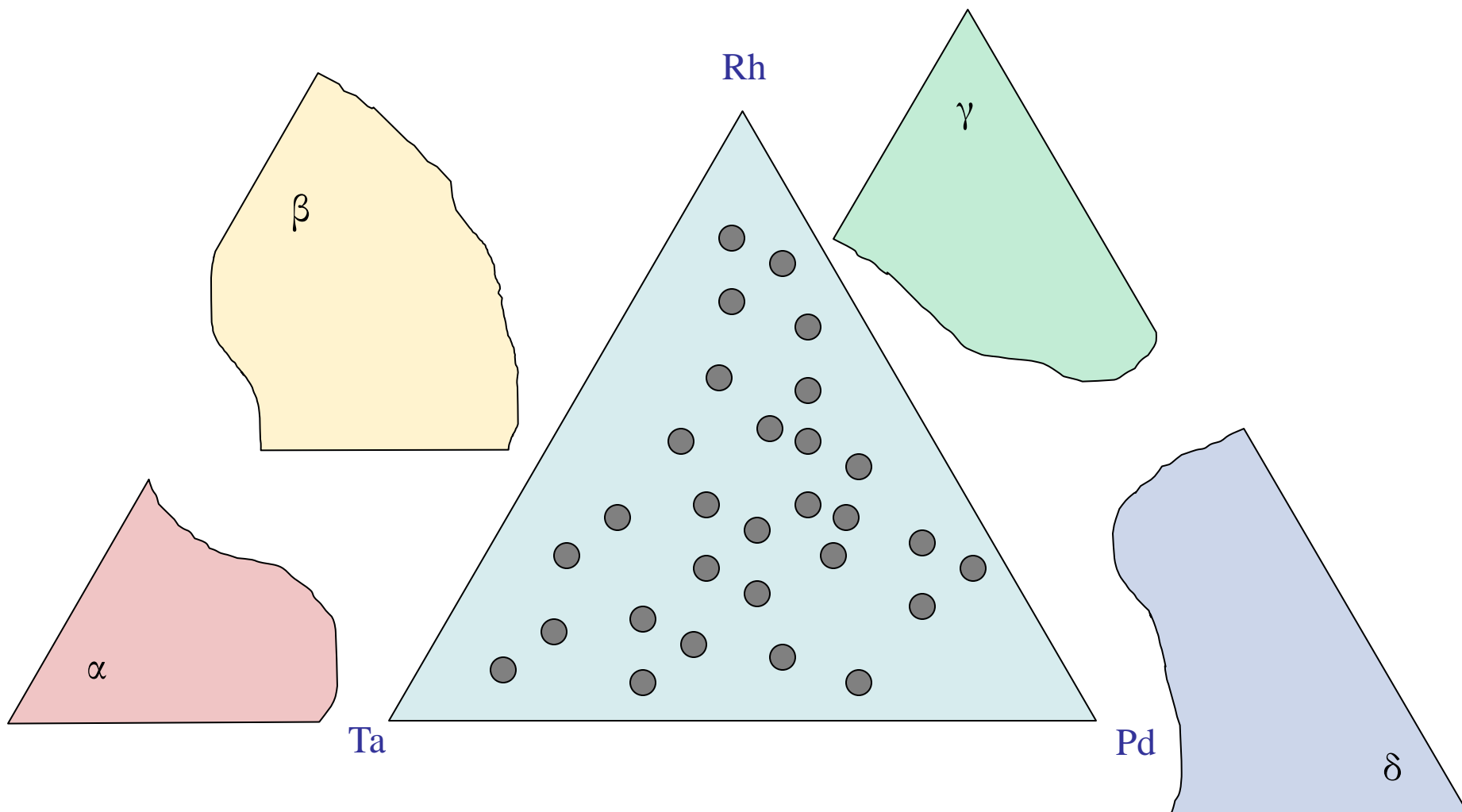
# Motivation



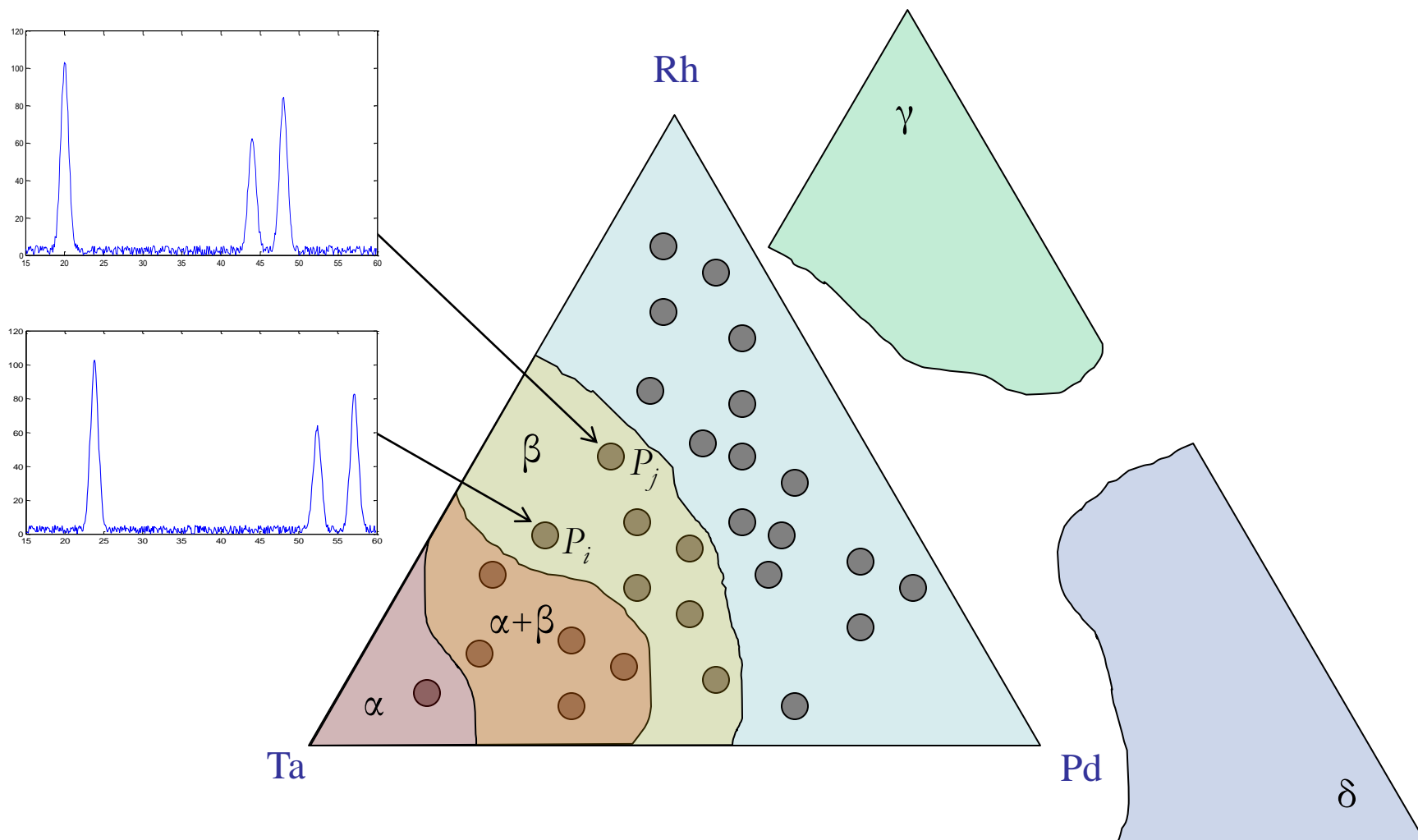
# Motivation



# Motivation

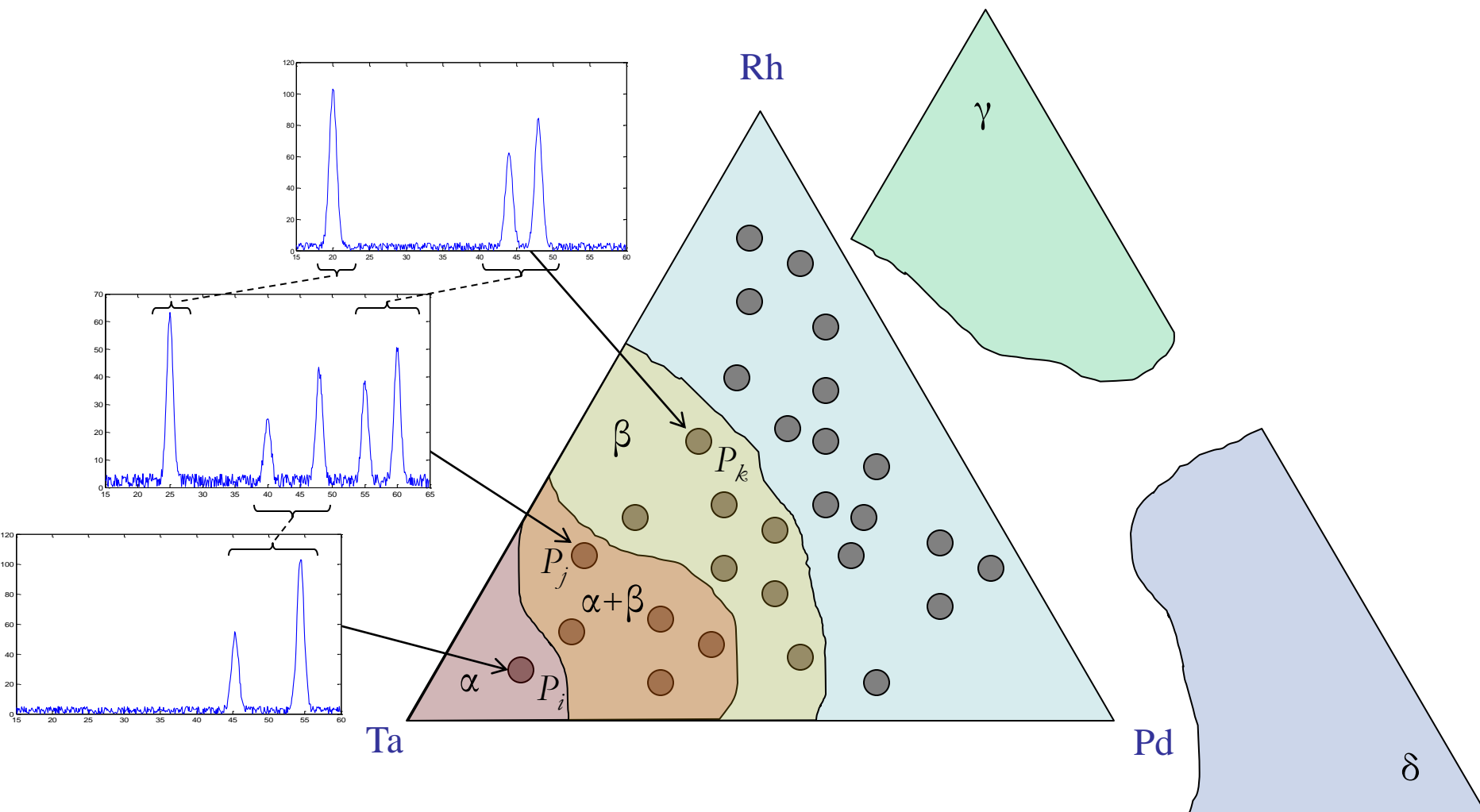


# Motivation



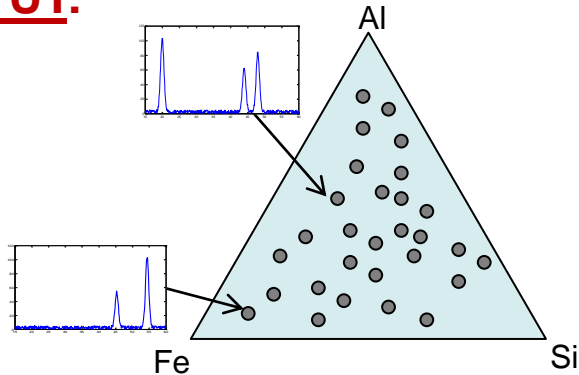


# Motivation



# Motivation

## INPUT:

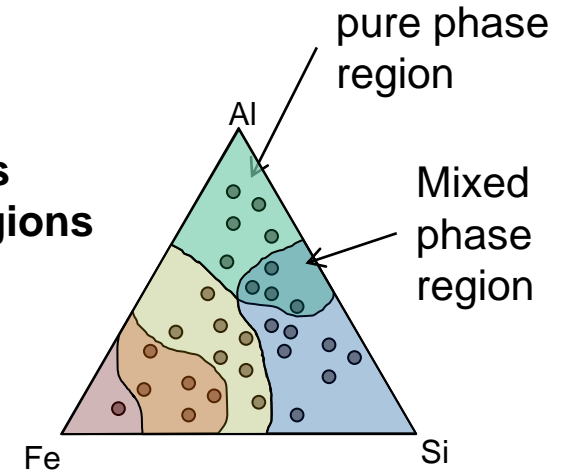


## OUTPUT:

*m* phase regions

- *k* pure regions
- *m-k* mixed regions

XRD pattern  
characterizing  
pure phases



## Additional Physical characteristics:

- Phase **Connectivity**
- Mixtures of  $\leq 3$  **pure phases**
- **Peaks shift by  $\leq 15\%$**  within a region
  - Continuous and Monotonic
- **Noisy detection**

# Motivation

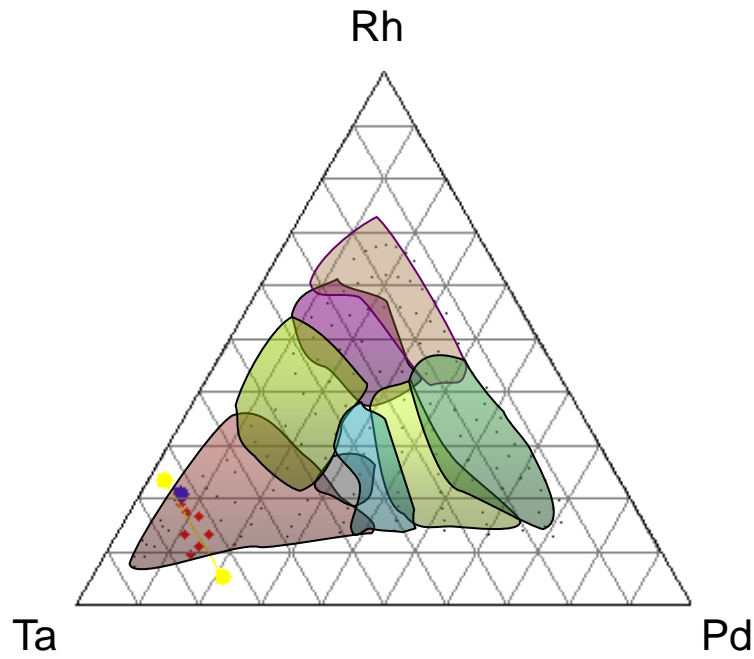


Figure 1: Phase regions of Ta-Rh-Pd

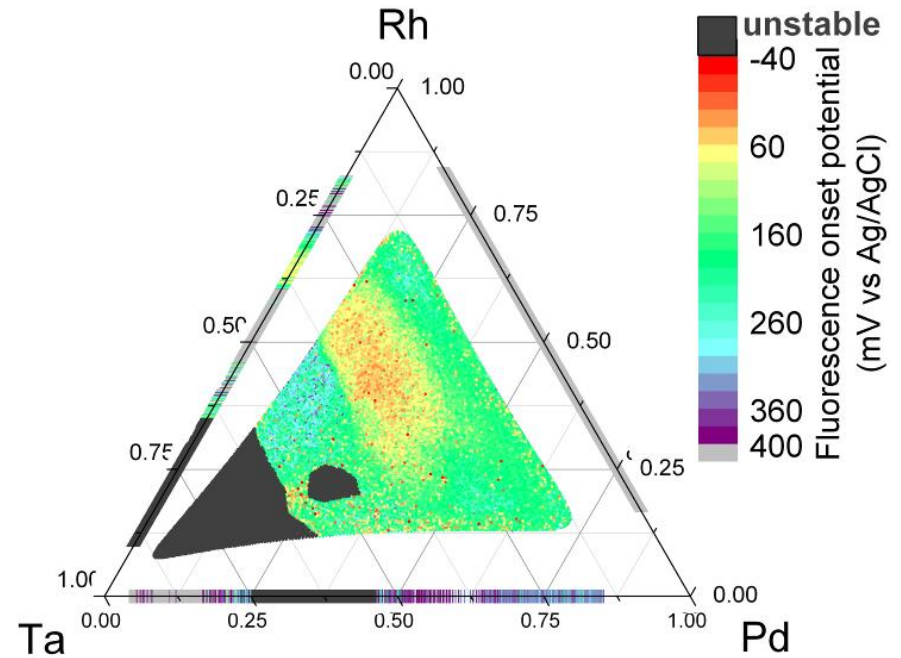


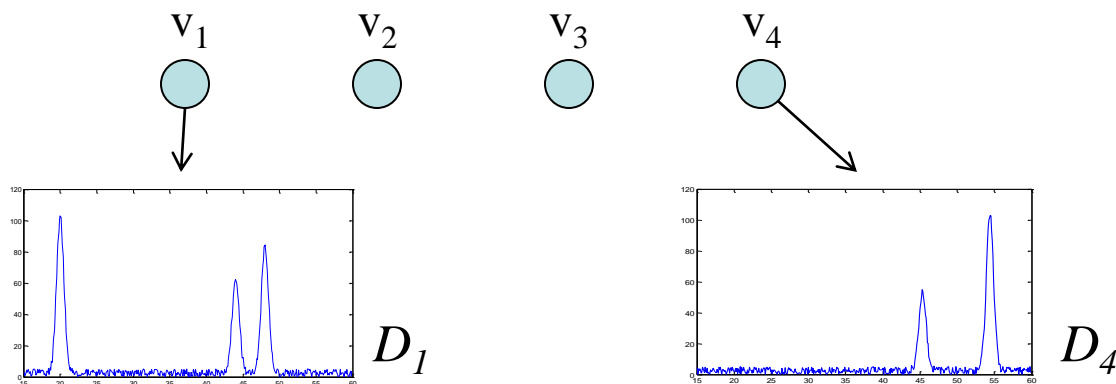
Figure 2: Fluorescence activity of Ta-Rh-Pd

- Motivation
- **Problem Definition (Part I)**
- Previous Work: Non-negative Matrix Factorization
- Problem Definition (Part II)
- Our Work: Satisfiability Modulo Theories Approach
- Conclusion and Future work

# Problem Definition (Part I)

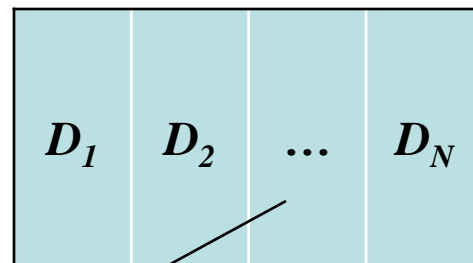
## • Input:

- A list of points on the silicon wafer



- A real vector  $D_i$  per vertex  $v_i$  (diffraction patterns)
- $K$  = user specified number of **pure phases**

- **Goal:** a basis of  $K$  vectors for

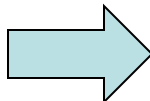


$$D_i = a_{i1}B_1 + \dots + a_{iK}B_K$$

# Problem Definition (Part I)

- There is **experimental noise**

$$D_i = a_{i1}B_1 + \dots + a_{iK}B_K$$



Minimize norm instead



$$\min \|D_i - (a_{i1}B_1 + \dots + a_{iK}B_K)\|$$

- **Non-negative** basis vectors and coefficients

$$B_i \geq 0, a_{ij} \geq 0$$

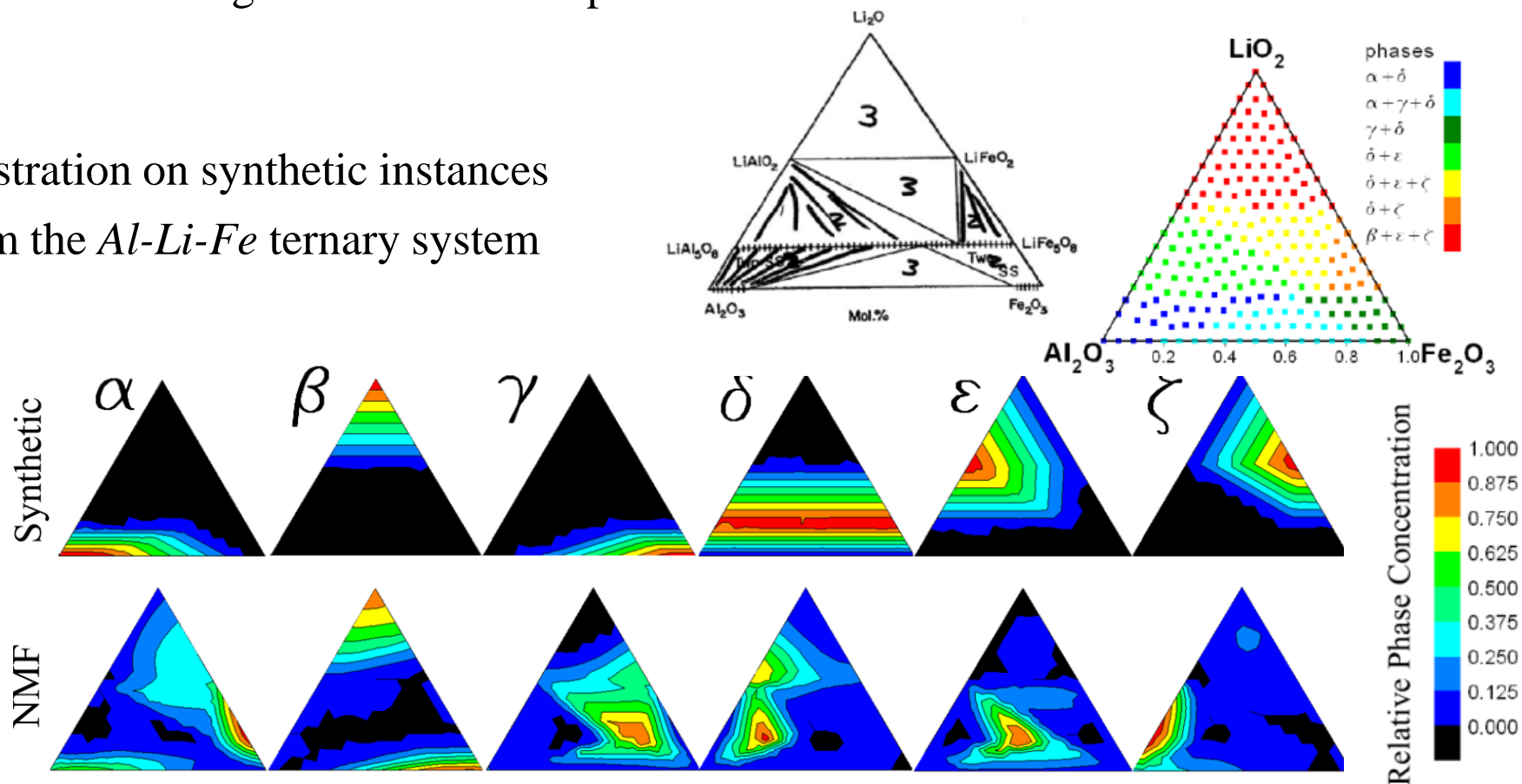
- Motivation
- Problem Definition (Part I)
- **Prior Work: Non-negative Matrix Factorization**
- Problem Definition (Part II)
- Our Work: Satisfiability Modulo Theories Approach
- Conclusion and Future work

# Non-negative Matrix Factorization [Long et al., 2009]

**Advantages:** scales up very well, accurately solves simple systems

**Drawbacks:** overlooks critical physical behavior, making the results physically meaningless for more complex systems.

Illustration on synthetic instances  
from the *Al-Li-Fe* ternary system



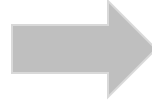


- Motivation
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# Problem Definition (Part II)

- There is **experimental noise**

$$D_i = a_{i1}B_1 + \dots + a_{iK}B_K$$



Minimize norm instead



$$\min \|D_i - (a_{i1}B_1 + \dots + a_{iK}B_K)\|$$

- **Non-negative** basis vectors and coefficients

$$B_i \geq 0, a_{ij} \geq 0$$

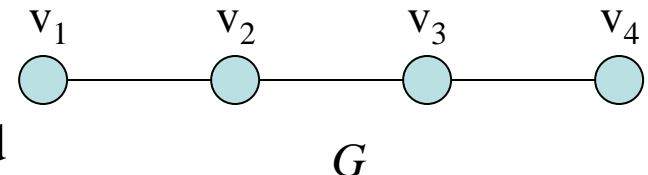
- **At most M (=3) non-zero coefficients** per point

$$|\{j \mid a_{ij} > 0\}| \leq M$$

- Basis patterns appear in **contiguous** locations on silicon wafer

Build a graph  $G$  of the points on the silicon wafer

The subgraph induced by  $\{i \mid a_{ij} > 0\}$  is connected

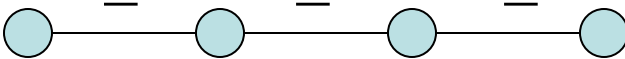


# Problem Definition (Part II)

- Basis vector can be **shifted**

$$\min \| \mathbf{D}_i - ( a_{i1} \overset{\substack{\text{Shift} \\ \text{operator}}}{S}(\mathbf{B}_1, s_{i1}) + \dots + a_{iK} \overset{\substack{\text{Shift} \\ \text{coefficients}}}{S}(\mathbf{B}_K, s_{iK}) ) \|$$

- Shifts coefficients are **bounded**, **continuous** and **monotonic**

$$s_{i1} \leq s_{i2} \leq s_{i3} \leq s_{i4}$$


$$|s_{i2} - s_{i1}| \leq c$$

# Outline

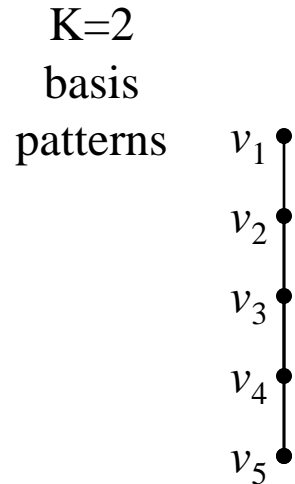
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- Motivation
- Problem Definition (Part I)
- Prior Work: Non-negative Matrix Factorization
- Problem Definition (Part II)
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- Conclusion and Future work

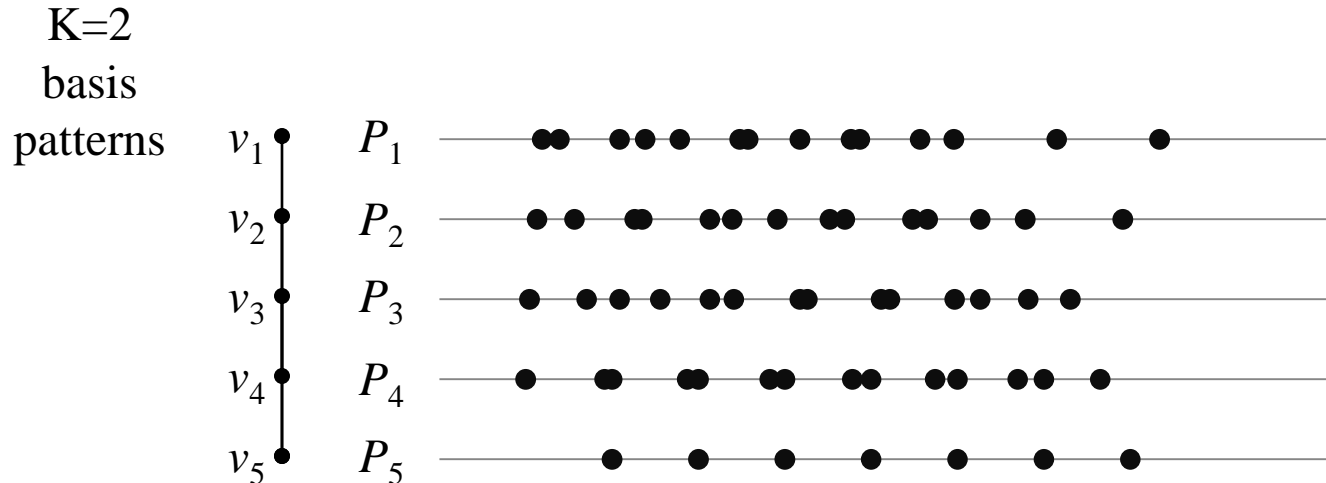
# Satisfiability Modulo Theories Approach

- Initial graph  $G$  and number  $K$  of basis patterns



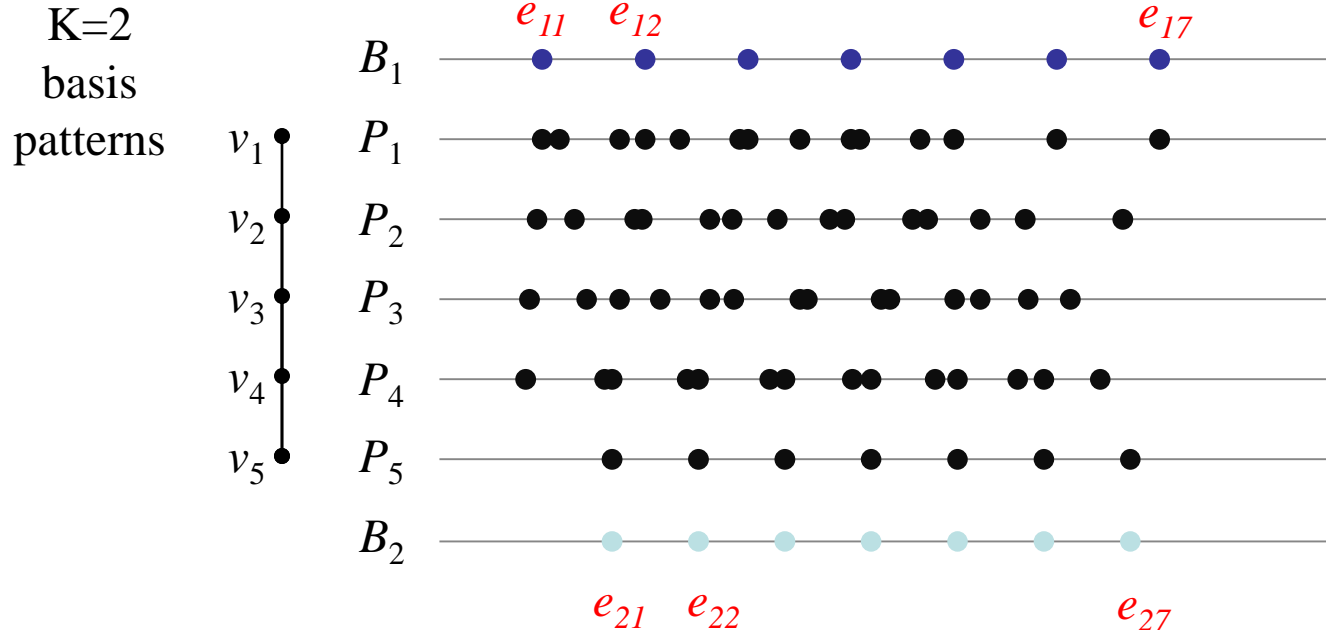
# Satisfiability Modulo Theories Approach

- Initial graph  $G$  and number  $K$  of basis patterns
- *Peak detection* to extract a set of peaks  $P_i$  for each diffraction pattern  $D_i$



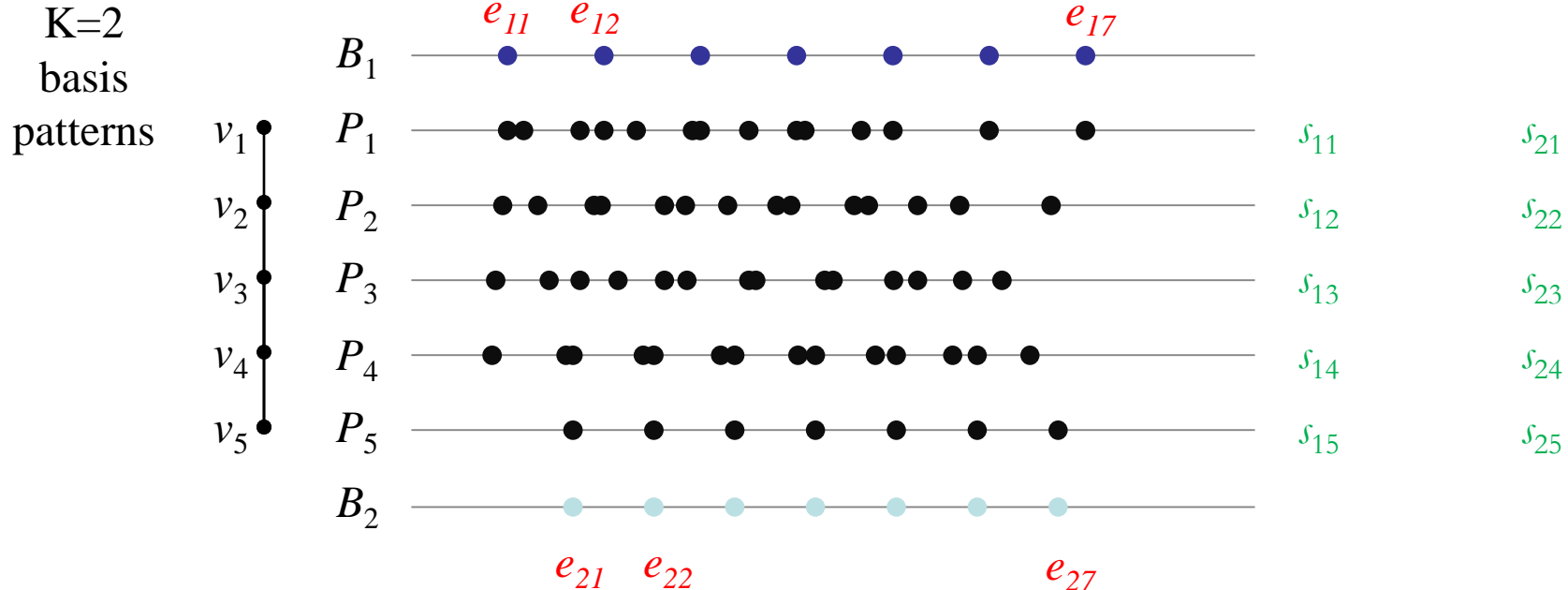
# Satisfiability Modulo Theories Approach

- Initial graph  $G$  and number  $K$  of basis patterns
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- Real variable  $e_{jk}$  for the **location of peak  $k$**  in basis  $B_j$



# Satisfiability Modulo Theories Approach

- Initial graph  $G$  and number  $K$  of basis patterns
- *Peak detection* to extract a set of peaks  $P_i$  for each diffraction pattern  $D_i$
- Real variable  $e_{jk}$  for the **location of peak**  $k$  in basis  $B_j$
- Real variable  $s_{ij}$  for the **shift** coefficient of basis  $B_j$  in point  $P_i$

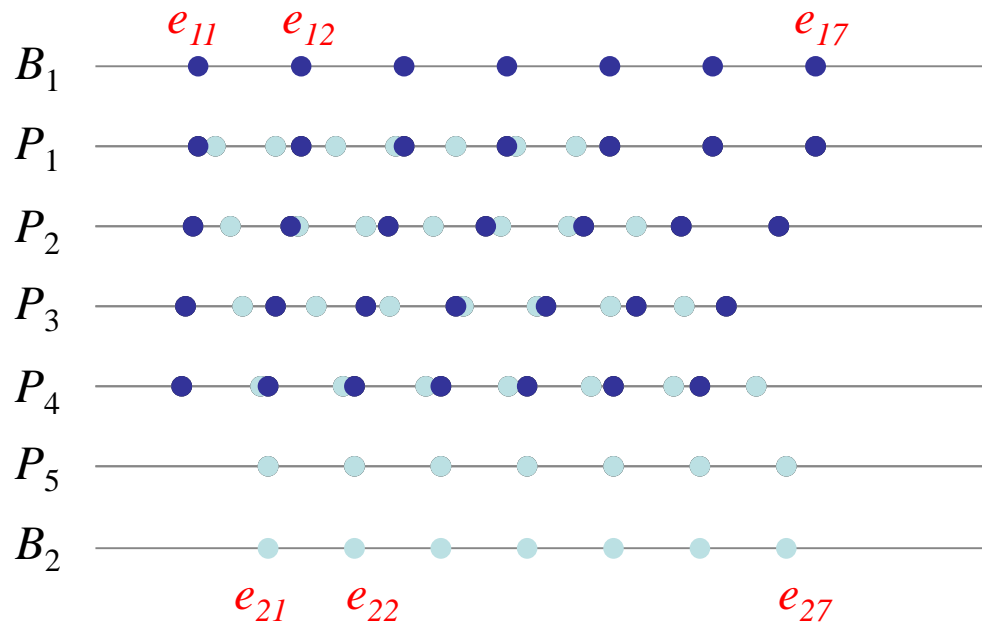
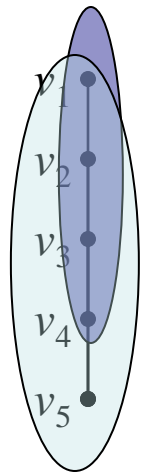




# Satisfiability Modulo Theories Approach

- An observed peak  $p$  is “*explained*” if there exists  $s_{ij}, e_{jk}$  s.t.  $|p - (s_{ij} + e_{jk})| \leq \varepsilon$
- Every observed peak must be *explained*

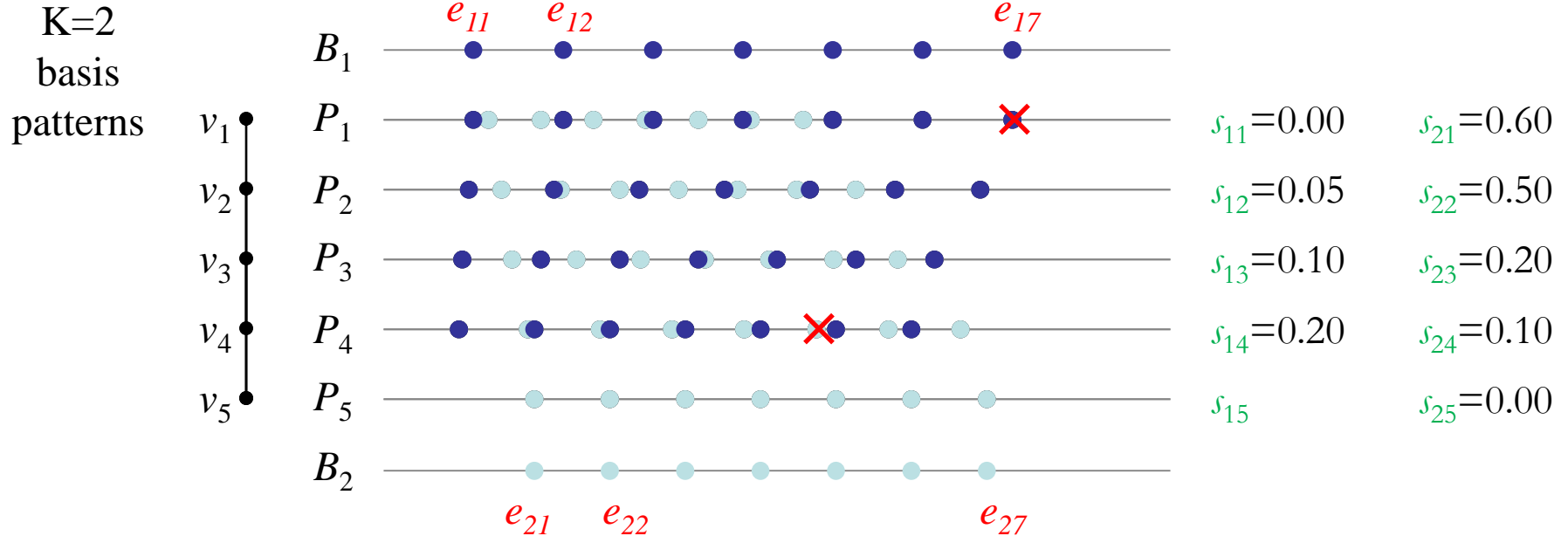
K=2  
basis  
patterns



$s_{11}=0.00$	$s_{21}=0.60$
$s_{12}=0.05$	$s_{22}=0.50$
$s_{13}=0.10$	$s_{23}=0.20$
$s_{14}=0.20$	$s_{24}=0.10$
$s_{15}$	$s_{25}=0.00$

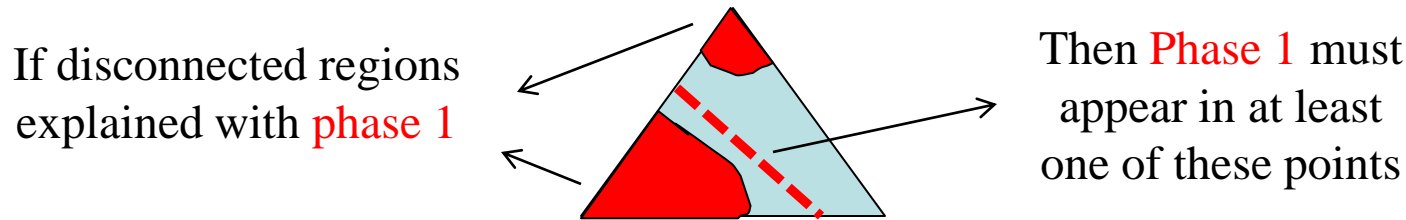
# Satisfiability Modulo Theories Approach

- An observed peak  $p$  is “*explained*” if there exists  $s_{ij}, e_{jk}$  s.t.  $|p - (s_{ij} + e_{jk})| \leq \varepsilon$
- Every observed peak must be *explained*
- Some peaks might be *missing* (unobserved)
- Bound the number of missing peaks  $\leq T$
- Minimization by (binary) search on  $T$



# Satisfiability Modulo Theories Approach

- Linear phase usage constraints (up to  $M$  basis patterns per point)
- Linear constraints for shift monotonicity and continuity (  $s_{ij} \leq s_{lm}$  )
- **Lazy connectivity**: add a cut if current solution is not connected

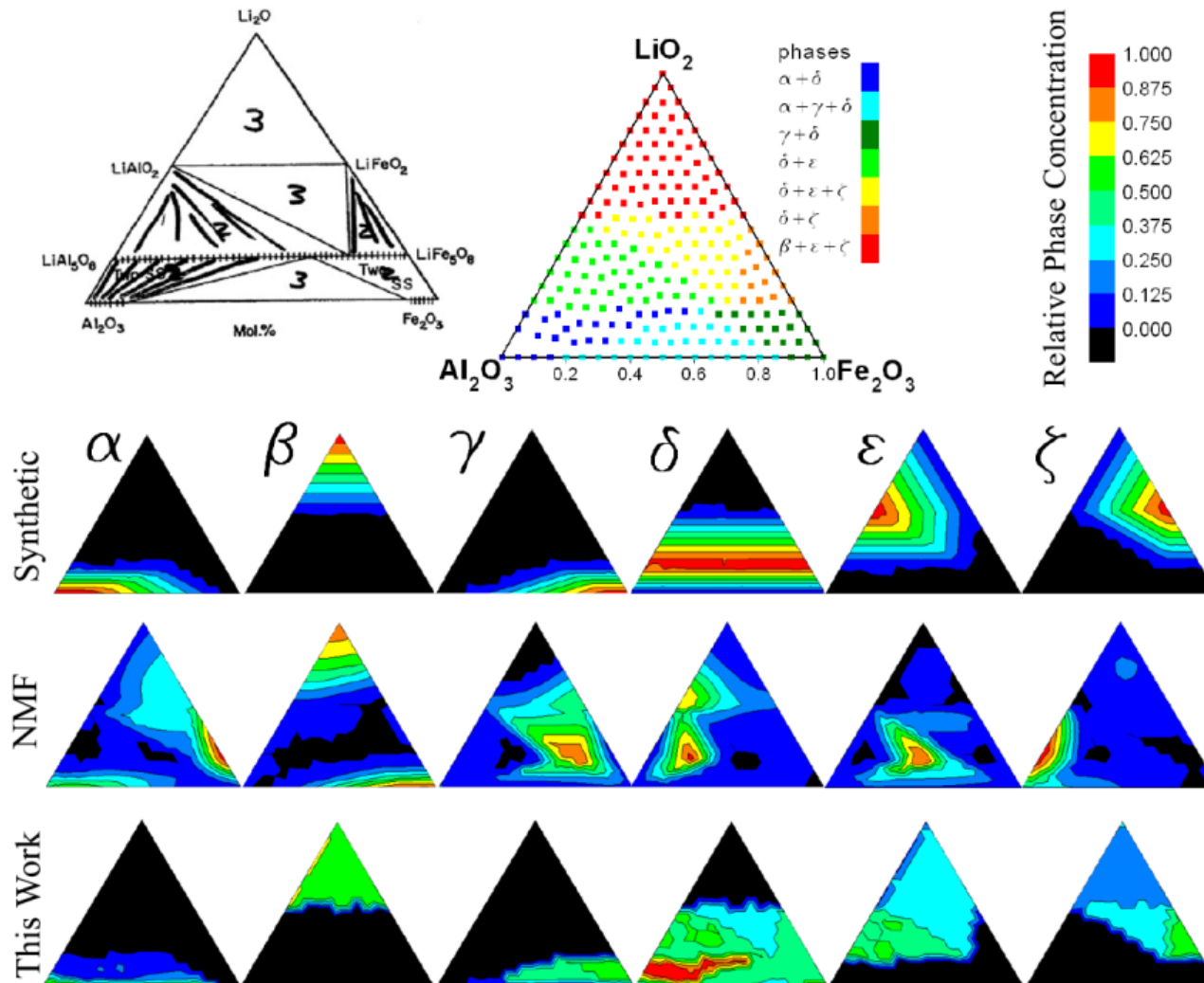


- **Symmetry breaking**:
  - Renaming of pure phases
  - Ordering of the peak locations  $e_{jk}$  (per basis pattern)

➡ **Quantifier-free linear arithmetic**

# Experimental Results

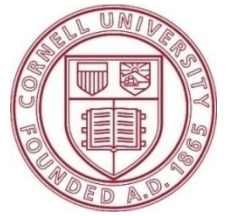
## •Illustration on Al-Li-Fe system



# Conclusion and Future work

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- Novel **SMT** encoding for Materials Discovery
- Good performance on synthetic data:
  - Scales to **realistic sized problems** (~50 points)
  - Provides **physically-meaningful** solutions
  - **Good accuracy** (>90% precision and recall)
  - Outperforms both Constraint Programming and Mixed Integer Programming direct translations of the SMT model
- **Future work:** online adaptive sampling during data collection
- Exciting results analyzing and explaining **real-world data**



# THANK YOU!

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# Extra slides

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# Runtime

# Points	Unknown Phases	Arithmetic + Z3 (s)	Set-based + CPLEX (s)
10	3	8	<b>0.5</b>
	6	<b>12</b>	Timeout
15	3	13	<b>0.5</b>
	6	<b>20</b>	Timeout
18	3	<b>29</b>	384.8
	6	<b>125</b>	Timeout
29	3	<b>78</b>	276
	6	<b>186</b>	Timeout
45	6	<b>518</b>	Timeout

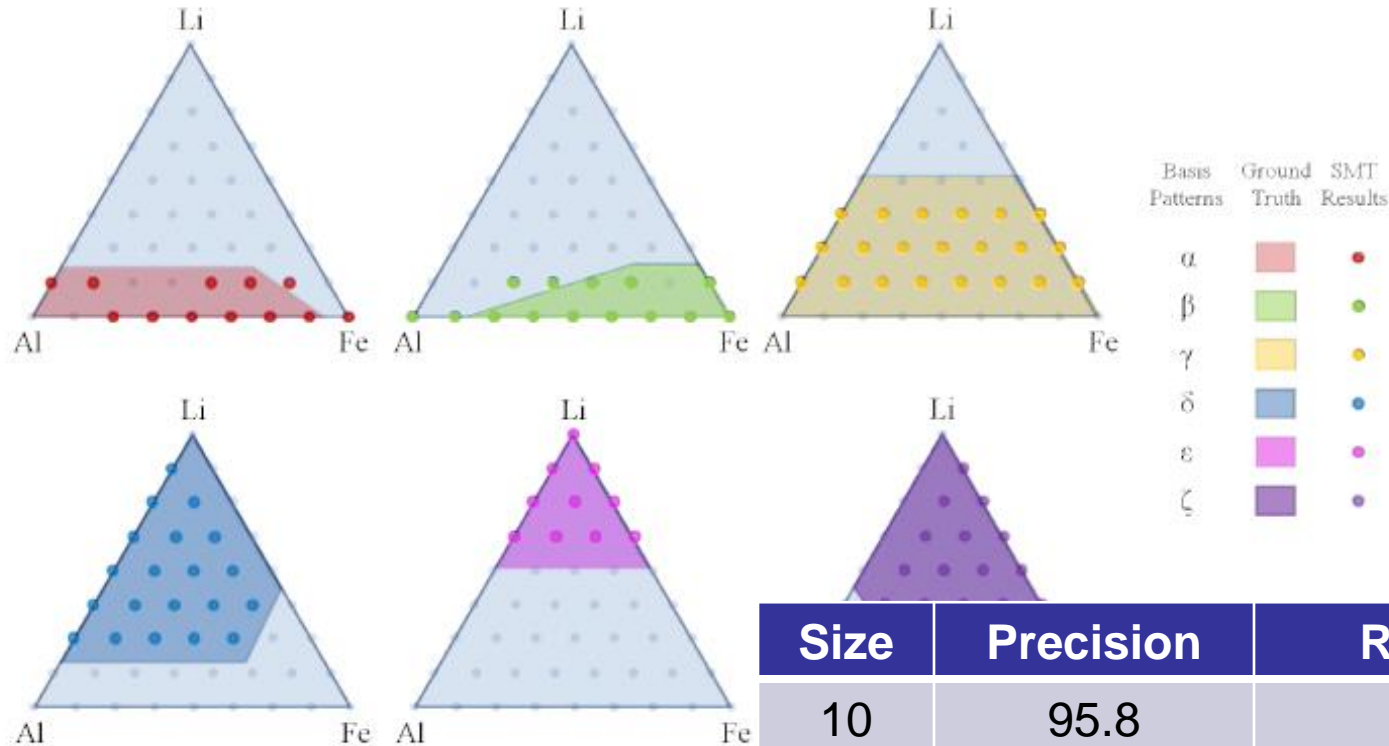
Z3 scales to realistic sized problems!

Arithmetic encoding translated to CP and MIP:

- MIP is appealing because it can optimize the objective
- They don't scale → **SMT solving strategy**



# Precision/Recall



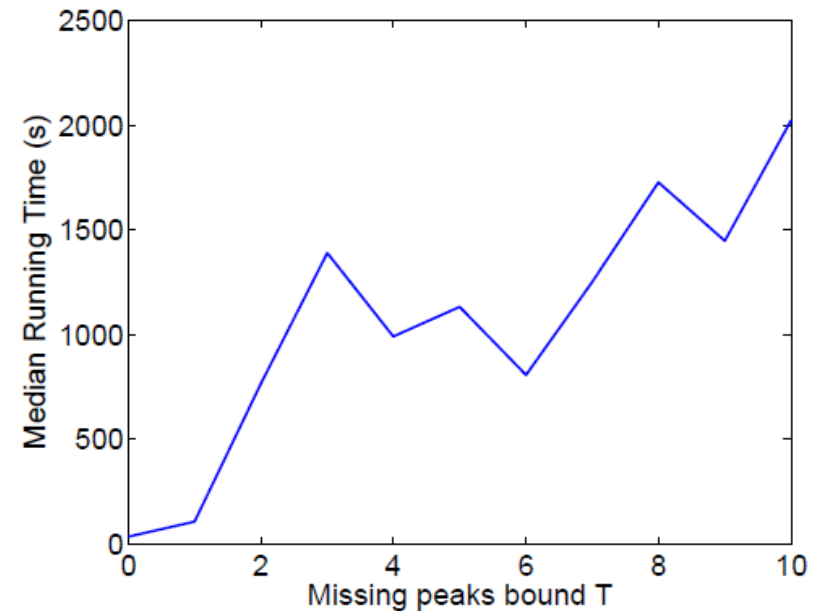
Recovers ground truth

Size	Precision	Recall
10	95.8	100
15	96.6	100
18	97.2	96.6
29	96.1	92.8
45	95.8	91.6

# Robustness

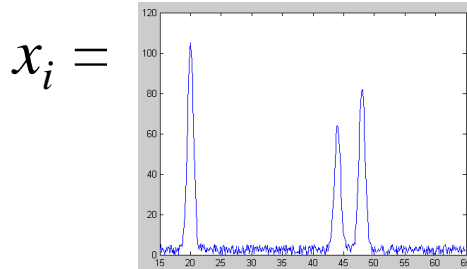
- Remove some peaks to simulate experimental noise
- Size = 15 points

Missing Peaks	Precision	Recall
1	96.1	99.6
2	96.3	99.3
3	96.7	99.5
4	95.3	98.9
5	94.8	99.7



Solutions are still **accurate**. Runtime increases approx **linearly**.

# Previous Work 1: Cluster Analysis [Long et al., 2007]

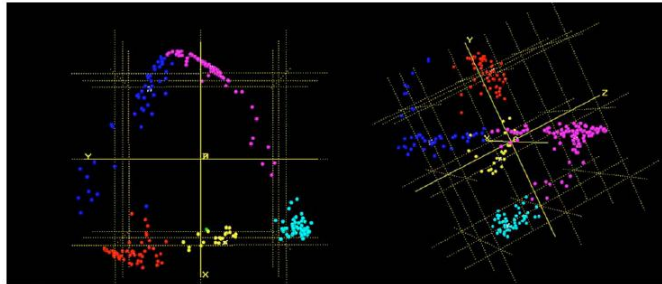


*Feature vector*

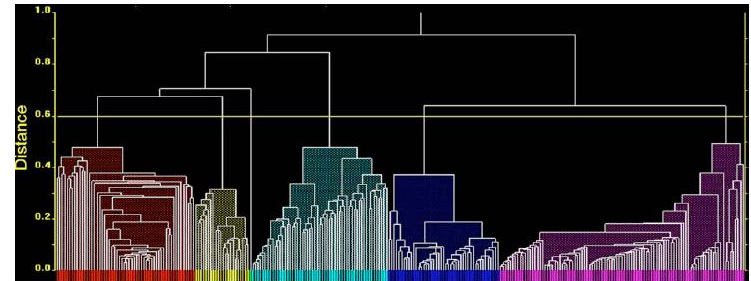
$$C_{xy} = \frac{\sum_{i=1}^n (x_i - \bar{x})(y_i - \bar{y})}{\left[ \sum_{i=1}^n (x_i - \bar{x})^2 \sum_{i=1}^n (y_i - \bar{y})^2 \right]^{1/2}} \longrightarrow D = (1 - C) / 2.$$

*Pearson correlation coefficients*

*Distance matrix*



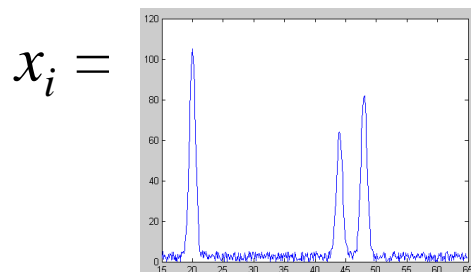
*PCA – 3 dimensional approx*



*Hierarchical Agglomerative Clustering*

**Drawback:** Requires sampling of pure phases, detects phase regions (not phases), overlooks peak shifts, may violate physical constraints (phase continuity, etc.).

# Previous Work 2: NMF [Long et al., 2009]

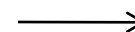


*Feature vector*



$$X = A.S + E$$

*Linear positive combination (A)  
of basis patterns (S)*



$$\text{Min } \|E\|$$

*Minimizing squared  
Frobenius norm*

**Drawback:** Overlooks peak shifts (linear combination only), may violate physical constraints (phase continuity, etc.).

- **Parameters**

- Number of pure phases  $K$ , tolerance  $\varepsilon$
- Key components
  - Variables peak positions per base
  - Shifts per point
  - Point  $p$  is explained by base  $k$

# SMT formulation

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- **New arithmetic-based encoding:**
  - Real variables  $e_{ij}$  for the peak locations in each  $B_i$
  - Real variables for the shift coefficients  $s_{ij}$   
(per base, per point)
  - An observed peak  $p$  is explained if  $|p - s_{ij} - e_{ij}| \leq \varepsilon$   
(Match the height of the peaks)
  - Bound the number of missing peaks  $\leq T$